

- N-Channel Enhancement Mode
- ◆ Low Q_g and R_g
- → High dv/dt
- Nanosecond Switching
- 30MHz Maximum Frequency

Symbol	Test Conditions	Maximum Ratings	
V _{DSS}	T _J = 25°C to 150°C	1000	V
\mathbf{V}_{DGR}	T_J = 25°C to 150°C; R_{GS} = 1 $M\Omega$	1000	V
V_{GS}	Continuous	±20	V
V_{GSM}	Transient	±30	V
I _{D25}	T _c = 25°C	24	Α
I _{DM}	T_{c} = 25°C, pulse width limited by T_{JM}	144	Α
I _{AR}	T _c = 25°C	21	Α
E _{AR}	T _c = 25°C	30	mJ
dv/dt	$\begin{split} &I_S \leq I_{DM}, \ di/dt \leq \ \ 100 A/\mu s, \ V_{DD} \leq V_{DSS}, \\ &T_j \leq 150^{\circ}C, \ R_G = 0.2\Omega \end{split}$	5	V/ns
	I _S = 0	>200	V/ns
P _{DC}		1800	W
P _{DHS}	T _c = 25°C Derate 4.0W/°C above 25°C	730	W
P _{DAMB}	T _c = 25°C	4.5	W
R _{thJC}		0.08	C/W
R _{thJHS}		0.20	C/W

Symbol	Test Conditions	Characteristic Values
-		$T_1 = 25^{\circ}$ C unless otherwise specified

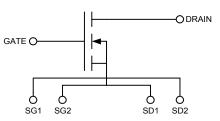
		min.	typ.	max.	
V _{DSS}	V_{GS} = 0 V, I_D = 3 ma	1000			V
V _{GS(th)}	$V_{DS} = V_{GS}$, $I_D = 4$ ma	3.5	4.4	5.5	V
I _{GSS}	$V_{GS} = \pm 20 \ V_{DC}, \ V_{DS} = 0$			±100	nA
I _{DSS}	$V_{DS} = 0.8 V_{DSS} T_J = 25^{\circ}C$ $V_{GS} = 0$ $T_J = 125^{\circ}C$			50 1	μA mA
R _{DS(on)}	V_{GS} = 15 V, I_{D} = 0.5 I_{D25} Pulse test, t \leq 300 μ S, duty cycle d \leq 2%			0.45	Ω
g fs	V_{DS} = 15 V, I_D = 0.5 I_{D25} , pulse test		12		S
T J		-55		+175	°C
T _{JM}			175		°C
T _{stg}		-55		+175	°C
T _L	1.6mm (0.063 in) from case for 10 s		300		°C
Weight			3		g

 V_{DSS} = 1000 V I_{D25} = 24 A

 $R_{DS(on)} \leq 0.45 \Omega$

 $P_{DC} = 1800W$





Features

- Isolated Substrate
- high isolation voltage (>2500V)
- excellent thermal transfer
- Increased temperature and power cycling capability
- IXYS advanced low Q_g process
- Low gate charge and capacitances
- easier to drive
- faster switching
- Low R_{DS(on)}
- Very low insertion inductance (<2nH)
- No beryllium oxide (BeO) or other hazardous materials

Advantages

- Optimized for RF and high speed switching at frequencies to 30MHz
- Easy to mount—no insulators needed
- · High power density



*DE475-102N21A*RF Power MOSFET

Characteristic Values

(T_J = 25°C unless otherwise specified)

		min.	typ.	max.
R_{G}			0.3	Ω
C _{iss}			5500	pF
Coss	V_{GS} = 0 V, V_{DS} = 0.8 $V_{DSS(max)}$, f = 1 MHz		190	pF
C _{rss}			52	pF
C _{stray}	Back Metal to any Pin		46	pF
$T_{d(on)}$			5	ns
\mathbf{T}_{on}	$V_{GS} = 15 \text{ V}, V_{DS} = 0.8 \text{ V}_{DSS}$ $I_D = 0.5 I_{DM}$		5	ns
$\mathbf{T}_{d(off)}$	$R_G = 0.2 \Omega$ (External)		5	ns
\mathbf{T}_{off}			8	ns
Q g(on)			155	nC
\mathbf{Q}_{gs}	V_{GS} = 10 V, V_{DS} = 0.5 V_{DSS} I_D = 0.5 I_{D25}		33	nC
\mathbf{Q}_{gd}			84	nC

Source-Drain Diode

Characteristic Values

(T_J = 25°C unless otherwise specified)

Symbol	Test Conditions	min.	typ.	max.	
Is	V _{GS} = 0 V			21	Α
I _{SM}	Repetitive; pulse width limited by T _{JM}			144	Α
V _{SD}	I_F = I_S , V_{GS} = 0 V, Pulse test, t \leq 300 μ s, duty cycle \leq 2%			1.5	V
T _{rr}			200		ns
\mathbf{Q}_{RM}	$I_F = I_S$, -di/dt = 100A/ μ s, $V_R = 100V$		0.6		μС
I _{RM}			8		Α

CAUTION: Operation at or above the Maximum Ratings values may impact device reliability or cause permanent damage to the device.

Information in this document is believed to be accurate and reliable. IXYSRF reserves the right to make changes to information published in this document at any time and without notice.

For detailed device mounting and installation instructions, see the "Device Installation & Mounting Instructions" technical note on the IXYSRF web site at;

http://www.ixysrf.com/pdf/switch_mode/appnotes/7de_series_mosfet_installation_instructions.pdf

IXYS RF reserves the right to change limits, test conditions and dimensions.

IXYS RF MOSFETS are covered by one or more of the following U.S. patents:

4,835,592	4,860,072	4,881,106	4,891,686	4,931,844	5,017,508
5,034,796	5,049,961	5,063,307	5,187,117	5,237,481	5,486,715
5,381,025	5,640,045				



DE475-102N21ARF Power MOSFET

Fig. 1 Typical Transfer Characteristics $V_{DS} = 50V$, $I_D = 12A$

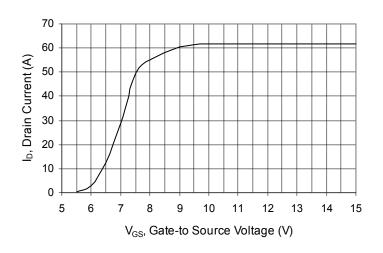
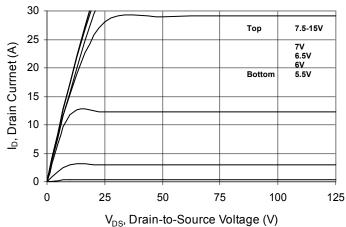


Fig. 2 Typical Output Characteristics $PW = 15 \mu S$



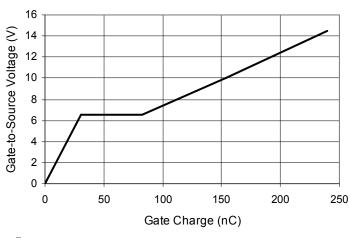


Fig. 4 Extended Typical Output Characteristics PW = 15 μS

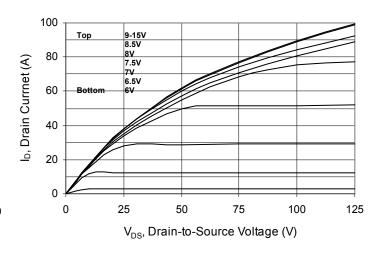


Fig. 5

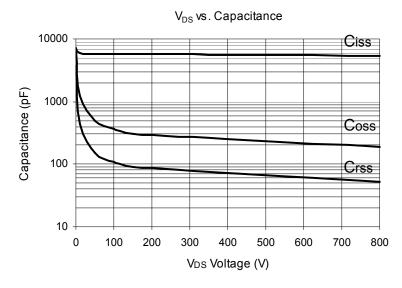
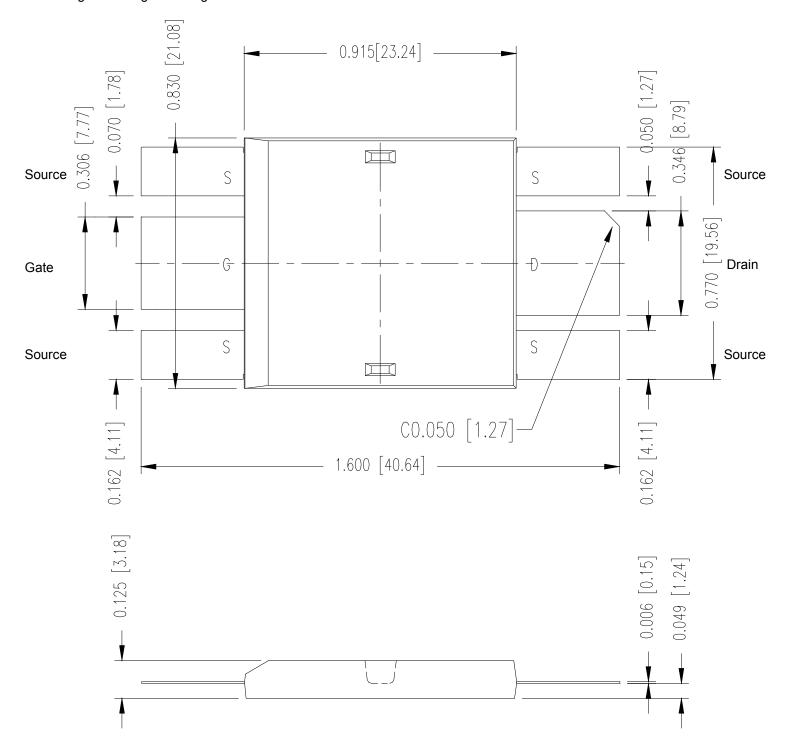




Fig. 6 Package Drawing





102N21A DE-SERIES SPICE Model (Preliminary)

The DE-SERIES SPICE Model is illustrated in Figure 7. The model is an expansion of the SPICE level 3 MOSFET model. It includes the stray inductive terms L_G , L_S and L_D . Rd is the $R_{DS(ON)}$ of the device, Rds is the resistive leakage term. The output capacitance, C_{OSS} , and reverse transfer capacitance, C_{RSS} are modeled with reversed biased diodes. This provides a varactor type response necessary for a high power device model. The turn on delay and the turn off delay are adjusted via Ron and Roff.

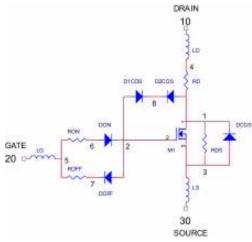


Figure 7 DE-SERIES SPICE Model

This SPICE model may be downloaded as a text file from the IXYSRF web site at

http://www.ixysrf.com/products/switch mode.html

http://www.ixysrf.com/spice/de475-102n21a.html

Net List:

.SUBCKT 102N21A 10 20 30

- * TERMINALS: D G S
- * 1000 Volt 21 Amp 0.45 ohm N-Channel Power MOSFET
- * REV.A 01-09-02

M1 1 2 3 3 DMOS L=1U W=1U

RON 5 6 0.3

DON 6 2 D1

ROF 5 7.1

DOF 2 7 D1

D1CRS 2 8 D2

D2CRS 1 8 D2

CGS 2 3 5.5N

RD 4 1 0.45

DCOS 3 1 D3

RDS 1 3 5.0MEG

LS 3 30.5N

LD 10 4 1N

LG 20 5 1N

.MODEL DMOS NMOS (LEVEL=3 VTO=3.0 KP=3.8)

.MODEL D1 D (IS=.5F CJO=1P BV=100 M=.5 VJ=.6 TT=1N)

.MODEL D2 D (IS=.5F CJO=400P BV=1000 M=.4 VJ=.6 TT=400N RS=10M)

.MODEL D3 D (IS=.5F CJO=900P BV=1000 M=.3 VJ=.4 TT=400N RS=10M) .ENDS Doc #9200-0247 Rev 6 © 2009 IXYS RF



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